

Description

Semicoa Semiconductors offers:

- Screening and processing per MIL-PRF-19500 Appendix E
- JAN level (2N4449J)
- JANTX level (2N4449JX)
- JANTXV level (2N4449JV)
- JANS level (2N4449JS)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV and JANS
- Radiation testing (total dose) upon request

Please contact Semicoa for special configurations
www.SEMICOA.com or (714) 979-1900

Applications

- High-speed switching transistor
- Low power
- NPN silicon transistor



Features

- Hermetically sealed TO-46 metal can
- Also available in chip configuration
- Chip geometry 0005
- Reference document: MIL-PRF-19500/317

Benefits

- Qualification Levels: JAN, JANTX, JANTXV and JANS
- Radiation testing available

| Absolute Maximum Ratings | | $T_c = 25^\circ\text{C}$ unless otherwise specified | |
|---|-----------------|---|----------------------------|
| Parameter | Symbol | Rating | Unit |
| Collector-Emitter Voltage | V_{CEO} | 15 | Volts |
| Collector-Base Voltage | V_{CBO} | 40 | Volts |
| Emitter-Base Voltage | V_{EBO} | 4.5 | Volts |
| Power Dissipation, $T_A = 25^\circ\text{C}$ Derate linearly above 25°C | P_T | 0.36 2.06 | mW mW/ $^\circ\text{C}$ |
| Thermal Resistance | $R_{\theta JA}$ | 325 | $^\circ\text{C}/\text{W}$ |
| Operating Junction Temperature | T_J | -65 to +200 | $^\circ\text{C}$ |
| Storage Temperature | T_{STG} | -65 to +200 | $^\circ\text{C}$ |

ELECTRICAL CHARACTERISTICS

characteristics specified at $T_A = 25^\circ\text{C}$

| Off Characteristics | | | | | | |
|--|---------------|--|---|-----|------|---------------|
| Parameter | Symbol | Test Conditions | Min | Typ | Max | Units |
| Collector-Emitter Breakdown Voltage | $V_{(BR)CEO}$ | $I_C = 10\text{ mA}$ | 15 | | | Volts |
| Collector-Base Cutoff Current | I_{CBO1} | $V_{CB} = 40\text{ Volts}$ | | | 10 | μA |
| | I_{CBO2} | $V_{CB} = 32\text{ Volts}$ | | | 0.2 | μA |
| | I_{CBO3} | $V_{CB} = 20\text{ Volts}, T_A = 150^\circ\text{C}$ | | | 30 | μA |
| Collector-Emitter Cutoff Current | I_{CEX} | $V_{CE} = 10\text{ Volts}, V_{EB} = 0.25\text{ Volts}$ $T_A = 125^\circ\text{C}$ | | | 30 | μA |
| Collector-Emitter Cutoff Current | I_{CES} | $V_{CE} = 20\text{ Volts}$ | | | 400 | nA |
| Emitter-Base Cutoff Current | I_{EBO1} | $V_{EB} = 4.5\text{ Volts}$ | | | 10 | μA |
| | I_{EBO2} | $V_{EB} = 4\text{ Volts}$ | | | 0.25 | μA |
| On Characteristics | | | Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$ | | | |
| Parameter | Symbol | Test Conditions | Min | Typ | Max | Units |
| DC Current Gain | h_{FE1} | $I_C = 10\text{ mA}, V_{CE} = 0.35\text{ Volts}$ | 40 | | 120 | |
| | h_{FE2} | $I_C = 30\text{ mA}, V_{CE} = 0.4\text{ Volts}$ | 30 | | 120 | |
| | h_{FE3} | $I_C = 10\text{ mA}, V_{CE} = 1\text{ Volts}$ | 40 | | 120 | |
| | h_{FE4} | $I_C = 100\text{ mA}, V_{CE} = 1\text{ Volts}$ | 20 | | 120 | |
| | h_{FE5} | $I_C = 10\text{ mA}, V_{CE} = 1\text{ Volts}$ $T_A = -55^\circ\text{C}$ | 20 | | | |
| Base-Emitter Saturation Voltage | V_{BEsat1} | $I_C = 10\text{ mA}, I_B = 1\text{ mA}$ | 0.70 | | 0.85 | Volts |
| | V_{BEsat2} | $I_C = 30\text{ mA}, I_B = 3\text{ mA}$ | | | 0.90 | |
| | V_{BEsat3} | $I_C = 100\text{ mA}, I_B = 10\text{ mA}$ | 0.80 | | 1.20 | |
| | V_{BEsat4} | $I_C = 10\text{ mA}, I_B = 1\text{ mA}, T_A = +125^\circ\text{C}$ | 0.59 | | | |
| | V_{BEsat5} | $I_C = 10\text{ mA}, I_B = 1\text{ mA}, T_A = -55^\circ\text{C}$ | | | 1.02 | |
| Collector-Emitter Saturation Voltage | V_{CEsat1} | $I_C = 10\text{ mA}, I_B = 1\text{ mA}$ | | | 0.20 | Volts |
| | V_{CEsat2} | $I_C = 30\text{ mA}, I_B = 3\text{ mA}$ | | | 0.25 | |
| | V_{CEsat3} | $I_C = 100\text{ mA}, I_B = 10\text{ mA}$ | | | 0.45 | |
| | V_{CEsat4} | $I_C = 10\text{ mA}, I_B = 1\text{ mA}, T_A = +125^\circ\text{C}$ | | | 0.30 | |
| Dynamic Characteristics | | | | | | |
| Parameter | Symbol | Test Conditions | Min | Typ | Max | Units |
| Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio | $ h_{FE} $ | $V_{CE} = 10\text{ Volts}, I_C = 10\text{ mA},$ $f = 100\text{ MHz}$ | 5 | | 10 | |
| Open Circuit Output Capacitance | C_{OBO} | $V_{CB} = 5\text{ Volts}, I_E = 0\text{ mA},$ $100\text{ kHz} < f < 1\text{ MHz}$ | | | 4 | pF |
| Open Circuit Input Capacitance | C_{IBO} | $V_{EB} = 0.5\text{ Volts}, I_C = 0\text{ mA},$ $100\text{ kHz} < f < 1\text{ MHz}$ | | | 5 | pF |
| Storage Time | t_s | $I_C = 10\text{ mA}, I_{B1} = I_{B2} = 10\text{ mA}$ | | | 13 | ns |
| Saturated Turn-On Time | t_{ON} | $I_C = 10\text{ mA}, I_{B1} = 3\text{ mA},$ $I_{B2} = 1.5\text{ mA}$ | | | 12 | ns |
| Saturated Turn-Off Time | t_{OFF} | $I_C = 10\text{ mA}, I_{B1} = 3\text{ mA},$ $I_{B2} = 1.5\text{ mA}$ | | | 18 | ns |